


<b>Search Notes</b>  	<b>Application/Control No.</b>  10522725	<b>Applicant(s)/Patent Under Reexamination</b>  KANAYAMA ET AL.
	<b>Examiner</b>  NOAH FRANK	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
524	407	5-8-08	NF

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search	5-8-08	NF
EAST search - see attached	4/6/2009	NF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/N. F./  
Examiner, Art Unit 1796